

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/586,244	ZAUMSEIL ET AL.	
Examiner		Art Unit		Page 1 of 1
MATTHEW W. SUCH		2891		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0167280	11-2002	Hayashi et al.	315/169.3
*	B	US-6,828,583	12-2004	Heeger et al.	257/40
*	C	US-2003/0102472	06-2003	Kelley et al.	257/40
*	D	US-7,638,793	12-2009	Chua et al.	257/40
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ruzyllo, J. Semiconductor Glossary: An Introduction to Semiconductor Terminology. 1st ED, Prosto Multimedia Publishing, State College, PA (2004): pp. 163.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.